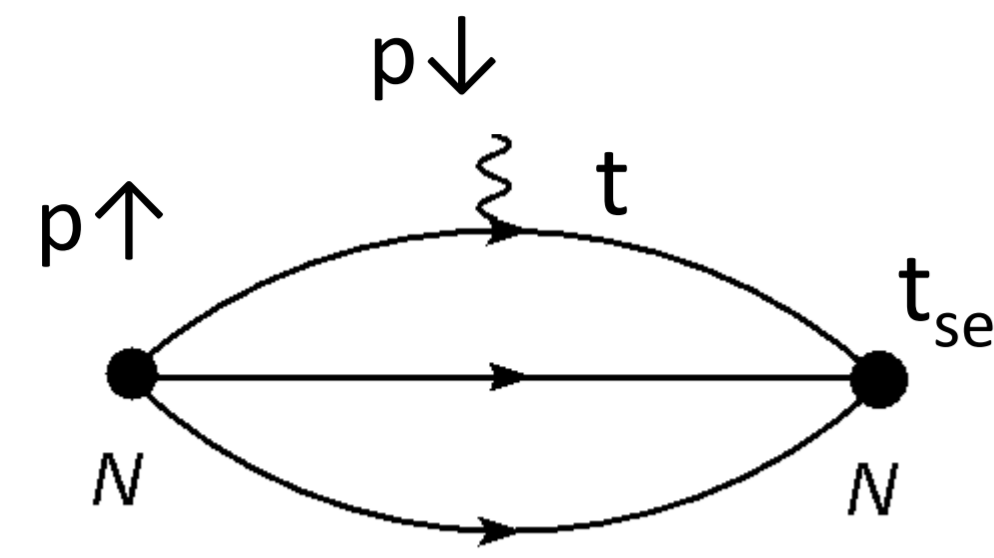


# Precise lattice calculation of nucleon form factor with all-mode-averaging

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## 1. Introduction and motivation

Lattice computation of nucleon EM form factor ( $G_{EM}$ ) and axial charge ( $G_A$ ) has still 10 times larger uncertainty than experimental result. The main issue is how to control excited state contamination



$$\sim e^{-E_N t - m_N (t_{sep} - t)} \times [\{G_X, g_A\} + c_1 e^{-\Delta(t_{sep} - t)} + c_2 e^{-\Delta' t}]$$

( $\Delta$  and  $\Delta'$  denote excited state mass difference.)

At  $t_{sep} \gg 1$  and  $t_{sep} - t \gg 1$ , excited state is suppressed, but signal-to-noise ratio becomes worse as  $S/N(t) \sim N^{1/2} \exp[-(m_N - 3m_\pi/2)t]$

This study is, to figure out what range of ground state dominance, we demonstrate **all-mode-averaging technique (AMA)** in form factor computation. By using AMA, statistical error can be reduced to 40% and less.

## 2. All-mode-averaging (AMA)

All-mode-averaging technique [1] is the recent idea to reduce the statistical error of correlation function in Monte-Carlo simulation. The AMA improved estimator is defined as

$$O^{(imp)} = O^{(rest)} + \frac{1}{N_G} \sum_{g \in G} O^{(appx),g}, \quad O^{(rest)} = O - O^{(appx)}$$

where we compute  $N_G$  approximation  $O^{(appx)}$  whose cost is much smaller than  $O$ . The lattice transformation  $g$  of the symmetry  $G$  is used for average of  $O^{(appx)}$ . The statistical error is reduced to

$$\frac{\sigma^{imp}}{\sigma} \simeq \sqrt{\frac{1}{N_G} + 2\Delta r + R^{corr}}, \quad R^{corr} = \frac{1}{N_G^2} \sum_{g \neq g'} r_{gg'}, \quad \Delta r = 1 - r$$

In this equation, the correlations are important factors,

$$r = \frac{\langle \Delta O \Delta O^{(appx)} \rangle}{\sigma \sigma^{(appx)}} \quad : \text{Correlation between } O^{(appx)} \text{ and } O$$

$$r_{gg'} = \frac{\langle \Delta O^{(appx),g} \Delta O^{(appx),g'} \rangle}{\sigma^{(appx),g} \sigma^{(appx),g'}} \quad : \text{Correlation between different } g$$

with  $\Delta O = O - \langle O \rangle$ . For error reduction, we need to search the approximation having small  $1-r$  and  $r_{gg'}$ . Here we deal with

- $G$  is translational invariance.
- $O^{(appx)}$  is constructed from fixed iter. in SAP + deflation + GCR [2]
- 3-parameters:

- Domain-size in SAP
- Number of deflation field
- Number of GCR iteration

control the quality of approximation and computational cost.

## 3. Lattice setting

Two-flavor dynamical Wilson-clover fermions configurations generated by CLS group is used in this simulation.

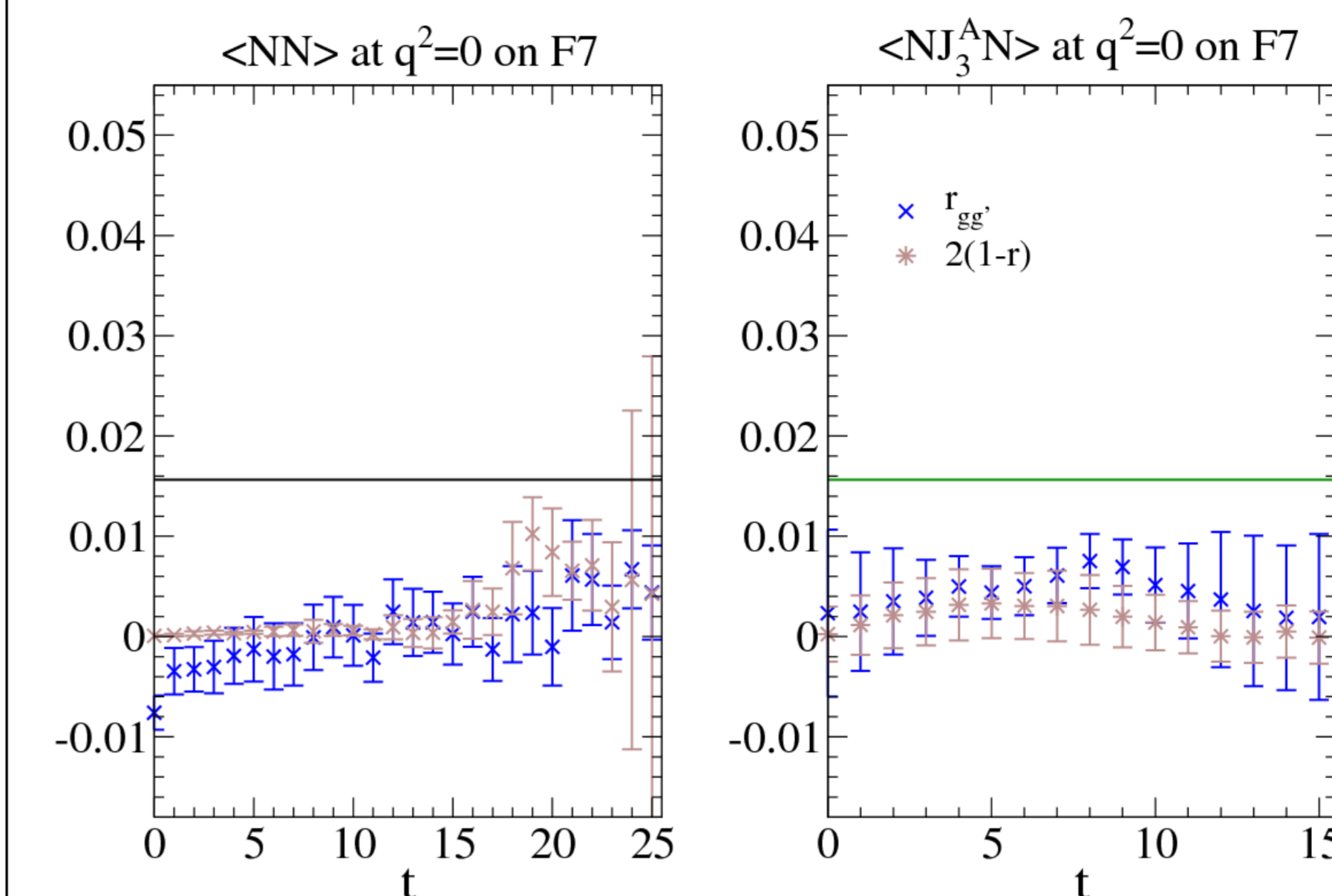
	Lattice	$a$ (fm)	$m_\pi$ (GeV)	$N_G$	$t_{sep}$ (fm)	#conf	#meas
B6	$96 \times 48^3$	0.079	0.267	64	0.79, 1.11, 1.26	~50	~3200
				112	1.42	48	5376
F7	$96 \times 48^3$	0.063	0.277	64	0.82, 0.95, 1.07	~100	~6400
				64	1.32	198	12672
				128	1.51	193	25344
N6	$96 \times 48^3$	0.05	0.332	64	0.9	17	1088
				32	1.1	40	1280
				32	1.3, 1.5	~180	5760
				G8	$128 \times 64^3$	0.063	0.193
				120	1.26	98	7680

## 4. AMA setting

	SAP domain size	$N_\lambda$	GCR iter. (2pt:3pt)	$x_{min}$ (fm)	Speed-up	• $N_\lambda$ : # of deflation • $x_{min}$ : Distance of different $O^{(appx),g}$ • Speed-up is just for solver part.
B6	$6 \times 6 \times 6 \times 6$	40	4:3	0.95	4--5	
F7	$6 \times 6 \times 6 \times 6$	30	4:3	0.76	6--7	
N6	$6 \times 6 \times 6 \times 6$	30	4:3	1.20	4--5	
G8	$8 \times 8 \times 8 \times 4$	40	4:3	1.01	5--6	

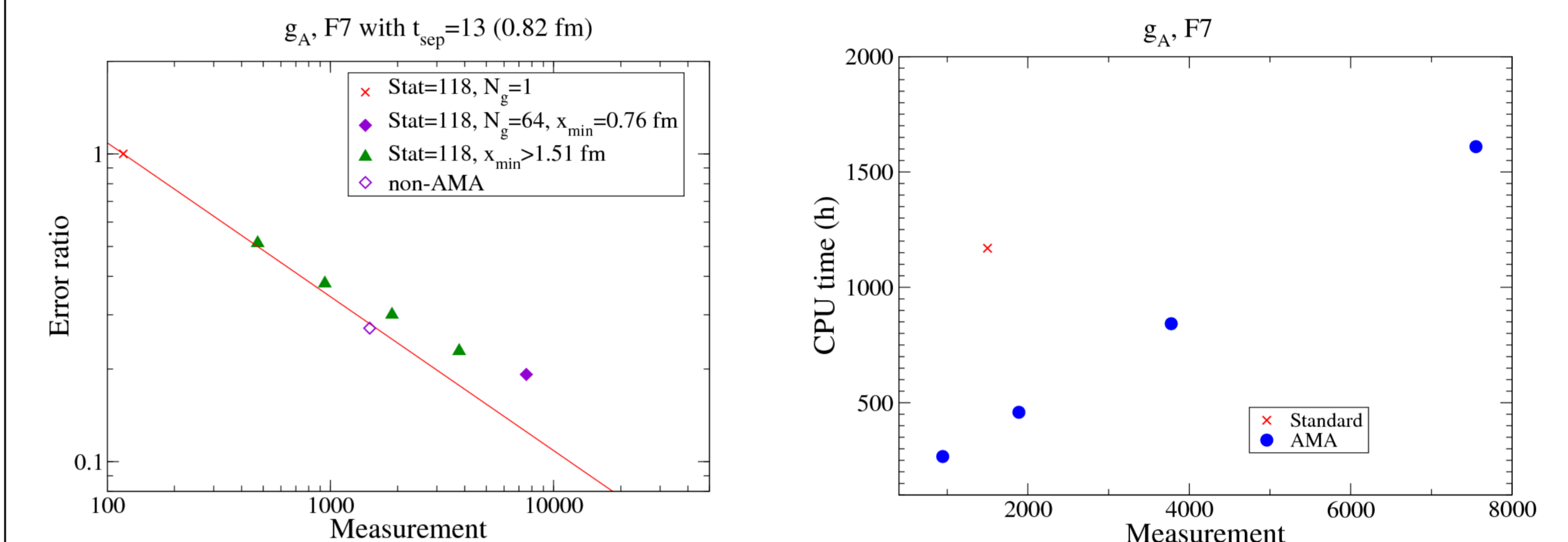
## 5. Performance of AMA

- $r$  and  $r_{gg'}$



- $2(1-r)$  and  $r_{gg'}$  are below  $1/N_G$  (solid line).
- Correlation is enough small rather than  $1/N_G$ , and then the statistical error is able to be controlled by  $N_G$

- Error scaling and computational cost

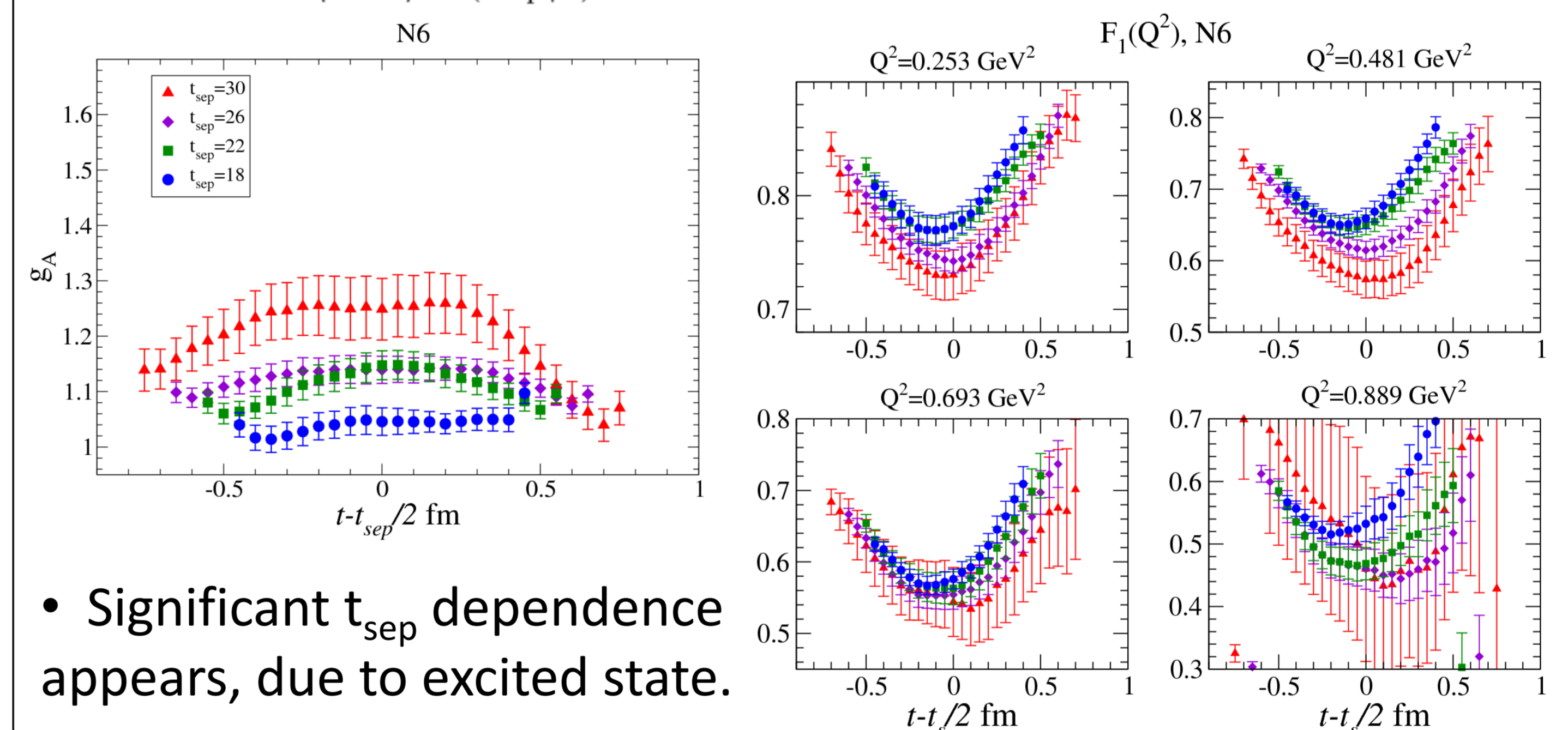


- Error ratio of  $g_A$ :  $\Delta g_A / g_A [AMA] / (\Delta g_A / g_A [118 \text{ stat, w/o AMA}])$
- Error scaling depends on  $[\text{meas}]^{1/2}$  if there is no correlation

## 6. Time-slice dependence

The ratio of 3pt and 2pt is to factor out the leading exponent,

$$R(t, t_{sep}) = \frac{\langle N J_\mu \bar{N} \rangle(t, t_{sep} | \vec{p})}{\langle N \bar{N} \rangle_{sm}(t_{sep} | \vec{0})} R_c(t, t_{sep} | \vec{p}) \simeq \{G_X, g_A\} + c_1 e^{-\Delta(t_{sep} - t)} + c_2 e^{-\Delta' t}$$



- Significant  $t_{sep}$  dependence appears, due to excited state.

## 7. Comparison of two extraction methods

Plateau method:

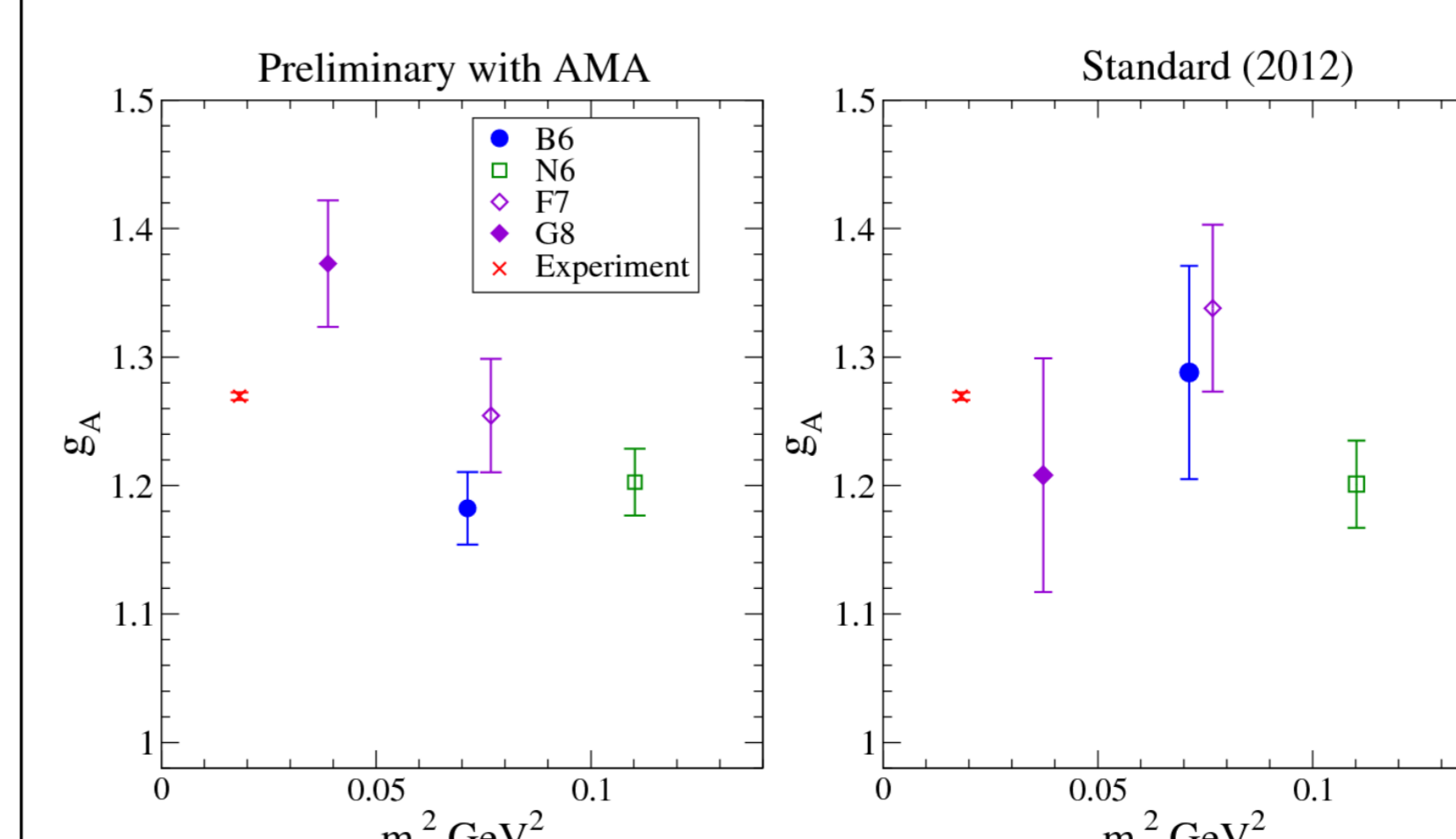
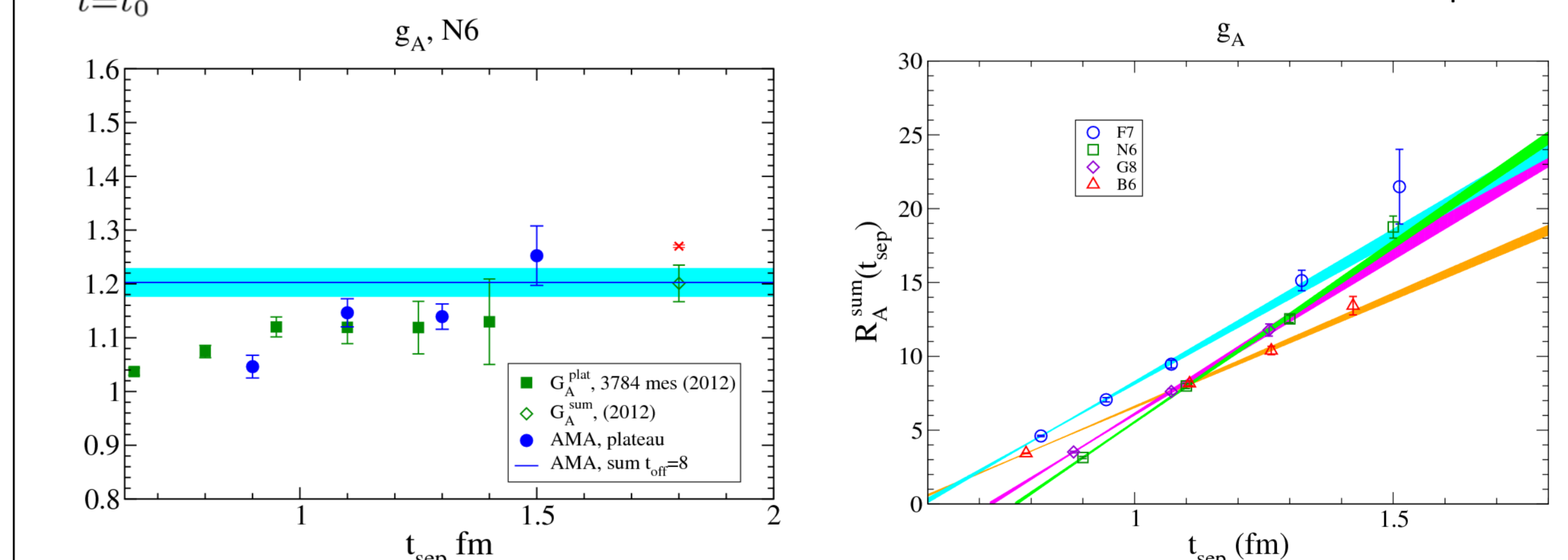
$$R(t, t_{sep}) \simeq \{G_X, g_A\} + \mathcal{O}(e^{-\Delta(t_{sep} - t)}, e^{-\Delta' t})$$

Constant fit in large  $t_{sep} - t$  and  $t$

Summation method [3,4]:

$$\sum_{t=t_0}^{t_1} R(t, t_{sep}) \simeq \text{const} + (t_1 - t_0) (\{G_X, g_A\} + \mathcal{O}(e^{-\Delta t_{sep}}))$$

Linear fit in large  $t_{sep}$



- The excited state contamination is not negligible below  $t_{sep} = 1$  fm.
- $t_{sep} > 1.3$  fm needs to control excited state.
- Statistical error is reduced as expected, but there still needs careful analysis of sys. error.